

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
30	0.004 at V _{GS} = 10 V	18	6.8 nC		
30	0.005 at V _{GS} = 4.5 V	16	0.0110		

SO-8

Top View

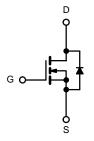
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FEATURES

- · Halogen-free
- TrenchFET® Power MOSFET
- Optimized for High-Side Synchronous Rectifier Operation
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Notebook CPU Core
 - High-Side Switch



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	5 T _A = 25 °C, unles	s otherwise note	d	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	v
	T _C = 25 °C		18	
Continuous Drain Current (T. 450 °C)	T _C = 70 °C		16	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	15 ^{b, c}	
	T _A = 70 °C		13 ^{b, c}	
Pulsed Drain Current		I _{DM}	50	A
Continuous Source-Drain Diode Current	T _C = 25 °C	1	3.8	
	T _A = 25 °C	I _S	2.1 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	22	
Avalanche Energy	L = 0.1 IIII	E _{AS}	24	mJ
	T _C = 25 °C		4.5	
Mandagua Barra Birata atau	T _C = 70 °C	D .	2.8	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	W
	T _A = 70 °C		1.6 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	38	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	22	28	C/VV	

Notes:

- a. Base on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				, ,,		<u> </u>
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250A		28		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7 0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	,	V _{DS} = 30 V, V _{GS} = 0 V			1	^
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
	_	V _{GS} = 10 V, I _D = 11 A		0.004		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A	0.005			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 11 A		52		S
Dynamic ^b	<u> </u>			<u> </u>		
Input Capacitance	C _{iss}			820		pF
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		195		
Reverse Transfer Capacitance	C _{rss}			73		
Tatal Cata Charma	Q_g $V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 11 \text{ A}$	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 11 A		15	23	nC
Total Gate Charge				6.8	10.2	
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 11 \text{ A}$		2.5		
Gate-Drain Charge	Q_{gd}			2.3		
Gate Resistance	R_g	f = 1 MHz	0.36	1.8	3.6	Ω
Turn-On Delay Time	t _{d(on)}			16	24	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		12	18	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		16	24	
Fall Time	t _f			10	20	ns
Turn-On Delay Time	t _{d(on)}			8	16	113
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		10	20	_ - -
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	24	
Fall Time	t _f			8	15	
Drain-Source Body Diode Characteris	ics					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			25	Α
Pulse Diode Forward Current ^a	I _{SM}				50	
Body Diode Voltage	V_{SD}	I _S = 9 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 9 A, dl/dt = 100 A/μs, T _J = 25 °C		6	12	nC
Reverse Recovery Fall Time	t _a	i _F = 0 Λ, αιναι = 100 Λ/μο, 1 _J = 20 0		8		nc
Reverse Recovery Rise Time	t _b	t _b		7		ns

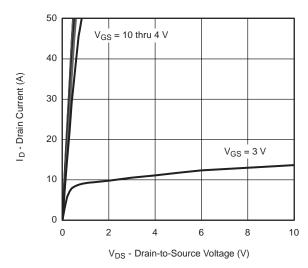
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

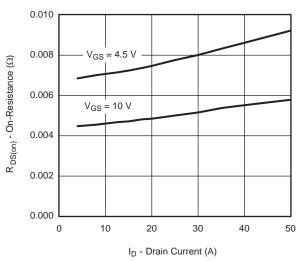
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



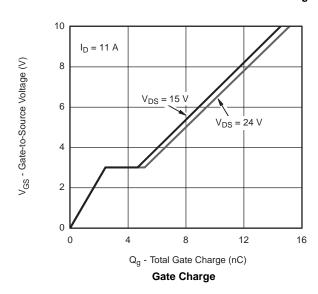
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



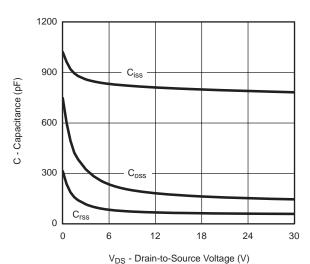
Output Characteristics



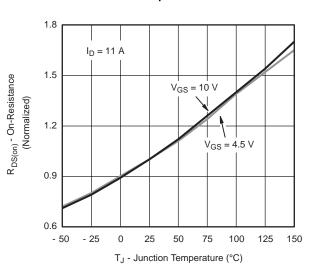
On-Resistance vs. Drain Current and Gate Voltage



V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**



Capacitance



On-Resistance vs. Junction Temperature

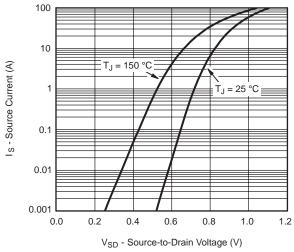
1.0

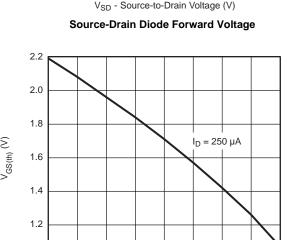
- 50

- 25



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





T_J - Temperature (°C)

Threshold Voltage

50

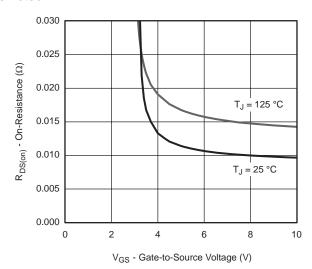
75

100

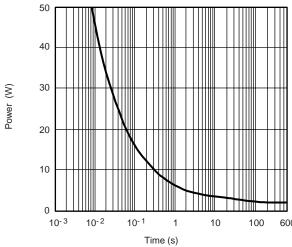
125

150

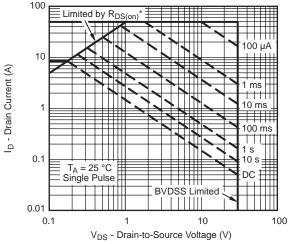
25



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

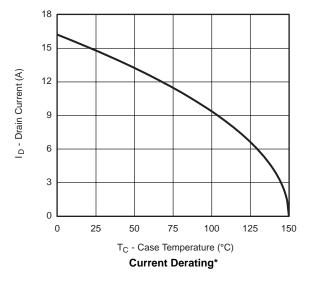


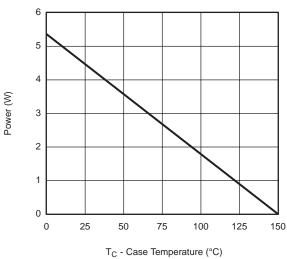
 * V $_{GS}$ > minimum V $_{GS}$ at which R $_{DS(on)}$ is specified

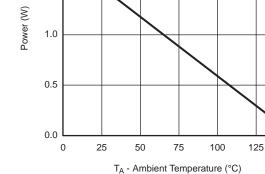
Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







Power Derating, Junction-to-Ambient

Power Derating, Junction-to-Foot

150 °C using impation to copy thermal registance, and is more useful in cettling the upper

2.0

1.5

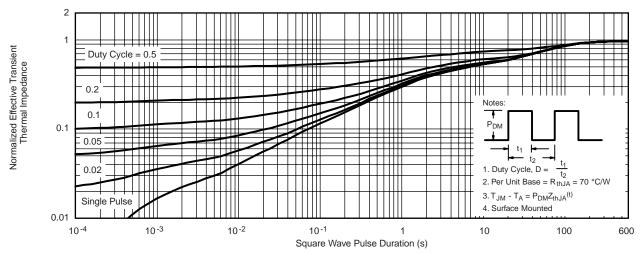
服务热线:400-655-8788

150

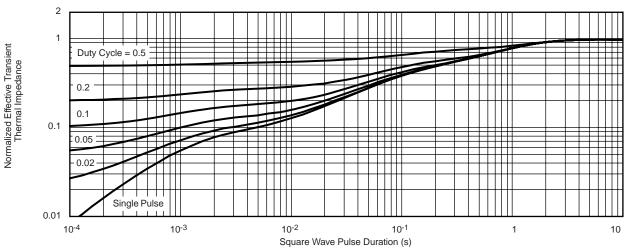
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



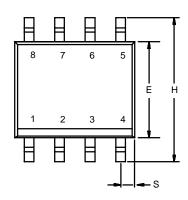
Normalized Thermal Transient Impedance, Junction-to-Ambient

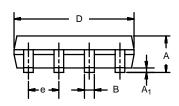


Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







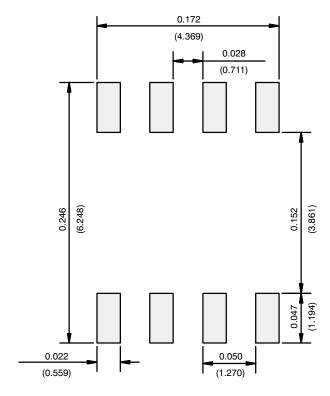
	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev I 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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